


<b>Search Notes</b>  	<b>Application/Control No.</b>  10550396	<b>Applicant(s)/Patent Under Reexamination</b>  TAKACHI, KEN
	<b>Examiner</b>  LHEIREN MAE A ANGLO	<b>Art Unit</b>  2833

SEARCHED			
Class	Subclass	Date	Examiner
200	302.2	6/15/09	LMA

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Primary, S. Sohn.	6/12/09	LMA
250/227.22.229.214sw,551,574 (text search only).	6/15/09	LMA
200/314 (text search only).	6/16/09	LMA
See EAST search history.	6/16/09	LMA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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